

STP90NF03L STB90NF03L-1

N-channel 30V - 0.0056Ω -90A TO-220/I²PAK Low gate charge STripFET™ Power MOSFET

General features

Туре	V _{DSS} (@Tjmax)	R _{DS(on)}	I _D
STP90NF03L	30V	<0.0065Ω	90A
STP90NF03L-1	30V	<0.0065Ω	90A

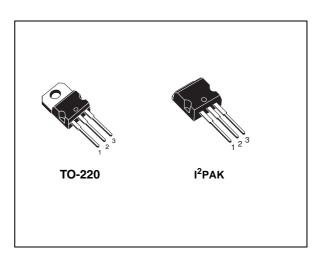
- Optimal R_{DS}(on) x Q_q trade-off
- Conduction losses reduced
- Switching losses reduced

Description

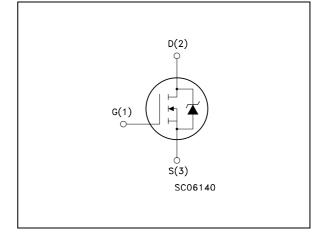
This application specific Power Mosfet is the third generation of STMicroelectronics unique "Single Feature Size[™]" strip-based process. The resulting transistor shows the best trade-off between on-resistance and gate charge. When used as high and low side in buck regulators, it gives the best performance in terms of both conduction and switching losses. This is extremely important for motherboards where fast switching and high efficiency are of paramount importance.

Applications

Switching application



Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STP90NF03L	P90NF03L	TO-220	Tube
STB90NF03L-1	B90NF03L	l ² PAK	Tube

September 2006

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1 Electrical ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage ($V_{GS} = 0$)	30	V
V _{GS}	Gate-source voltage	± 20	V
I _D	Drain current (continuous) at $T_C = 25^{\circ}C$	90	Α
I _D	Drain current (continuous) at $T_C=100^{\circ}C$	65	А
I _{DM} ⁽¹⁾	Drain current (pulsed)	360	Α
P _{TOT}	Total dissipation at $T_C = 25^{\circ}C$	150	W
	Derating factor	0.73	W/°C
TJ	Operating junction temperature	-65 to 175	°C
T _{stg}	Storage temperature	175	

1. Pulse width limited by safe operating area

Table 2. Thermal data

R _{thj-case}	Thermal resistance junction-case Max	1	°C/W
R _{thj-a}	Thermal resistance junction-ambient Max	62.5	°C/W
TI	Maximum lead temperature for soldering purpose	300	°C



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2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

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Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 250 μA, V _{GS} = 0	30			V
I _{DSS}	Zero gate voltage drain current ($V_{GS} = 0$)	V _{DS} = Max rating, V _{DS} = Max rating @125°C			1 10	μA μA
I _{GSS}	Gate body leakage current (V _{DS} = 0)	$V_{GS} = \pm 20V$			± 100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1		2.5	V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10V, I _D = 45A V _{GS} = 5V, I _D = 45A		0.0056 0.007	0.0065 0.012	Ω Ω

Table 3. On/off states

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
g _{fs} ⁽¹⁾	Forward transconductance	V _{DS} > ID(on) x RDS(on)max _, I _D = 45A		40		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} =25V, f=1 MHz, V _{GS} =0		2700 860 170		pF pF pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V _{DD} =24V, I _D = 90A V _{GS} =5V		35 10 18	47	nC nC nC

1. Pulsed: pulse duration=300µs, duty cycle 1.5%

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r	Turn-on delay time rise time	$V_{DD} = 15V, I_D = 45A,$ $R_G = 4.7\Omega, V_{GS} = 4.5V$ (see Figure 12)		30 200		ns ns
t _{d(off)} t _f	Turn-off-delay time fall time	$V_{DD} = 15V, I_D = 45A,$ $R_G = 4.7\Omega, V_{GS} = 4.5V$ (see Figure 12)		50 105		ns ns

Table 5. Switching times

Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I _{SD}	Source-drain current				90	А
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)				360	А
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} =90A, V _{GS} =0			1.3	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} =90A, di/dt = 100A/μs, V _{DD} =15V, Tj=150°C (see Figure 14)		80 90 2.5		ns μC Α

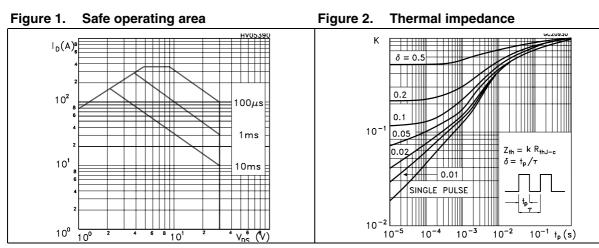
Table 6.Source drain diode

1. Pulse width limited by safe operating area

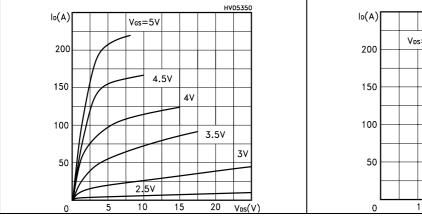
2. Pulsed: pulse duration=300µs, duty cycle 1.5%

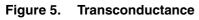


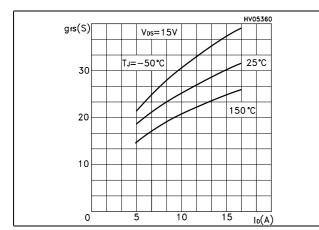
2.1 Electrical characteristics (curves)













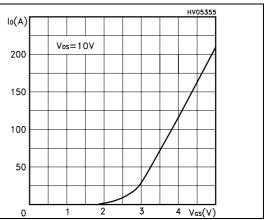
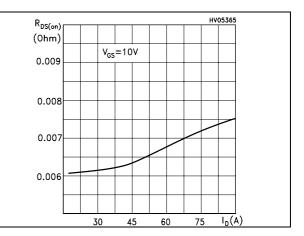


Figure 6. Static drain-source on resistance



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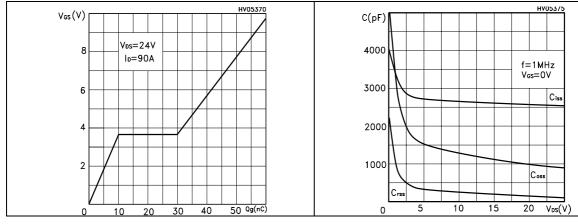
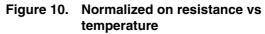


Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

Figure 9. Normalized gate threshold voltage vs temperature



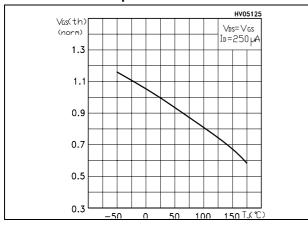
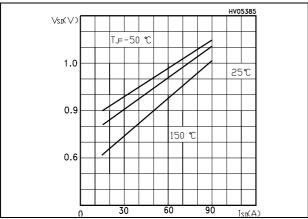
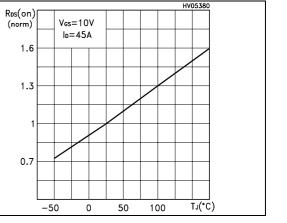


Figure 11. Source-drain diode forward characteristics



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3 Test circuit

Figure 12. Switching times test circuit for resistive load

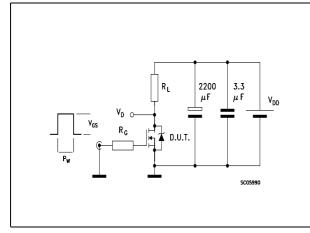
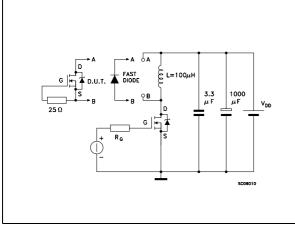


Figure 14. Test circuit for inductive load switching and diode recovery times





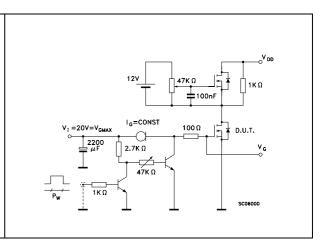


Figure 15. Unclamped Inductive load test circuit

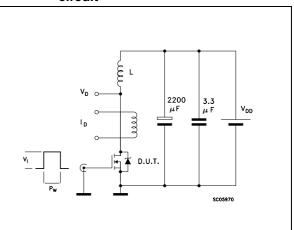
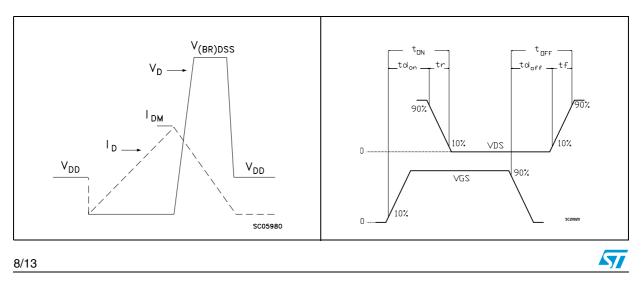


Figure 17. Switching time waveform



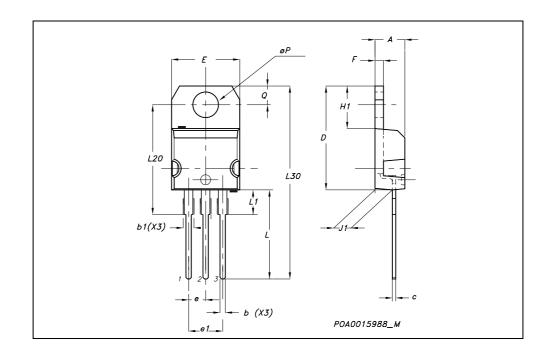
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com



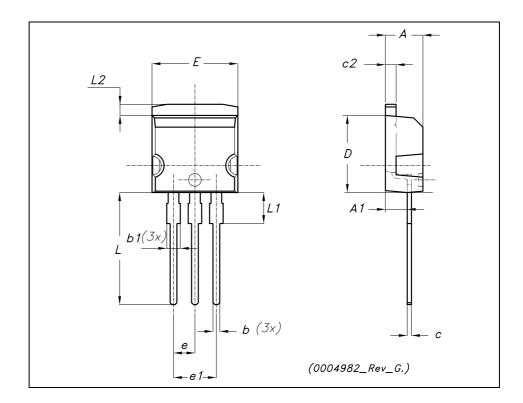
DIM.		mm.			inch	n		
DIN.	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.		
А	4.40		4.60	0.173		0.181		
b	0.61		0.88	0.024		0.034		
b1	1.15		1.70	0.045		0.066		
С	0.49		0.70	0.019		0.027		
D	15.25		15.75	0.60		0.620		
E	10		10.40	0.393		0.409		
е	2.40		2.70	0.094		0.106		
e1	4.95		5.15	0.194		0.202		
F	1.23		1.32	0.048		0.052		
H1	6.20		6.60	0.244		0.256		
J1	2.40		2.72	0.094		0.107		
L	13		14	0.511		0.551		
L1	3.50		3.93	0.137		0.154		
L20		16.40			0.645			
L30		28.90			1.137			
øP	3.75		3.85	0.147		0.151		
Q	2.65		2.95	0.104		0.116		





DIM		mm.			inch	
DIM.	MIN.	TYP MAX. MIN.		TYP.	MAX.	
А	4.40		4.60	0.173		0.181
A1	2.40		2.72	0.094		0.107
b	0.61		0.88	0.024		0.034
b1	1.14		1.70	0.044		0.066
С	0.49		0.70	0.019		0.027
c2	1.23		1.32	0.048		0.052
D	8.95		9.35	0.352		0.368
е	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
E	10		10.40	0.393		0.410
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L2	1.27		1.40	0.050		0.055

TO-262 (I²PAK) MECHANICAL DATA





5 Revision history

Date	Revision	Changes
09-Sep-2004	4	Complete version
17-Aug-2006	5	New template, no content change



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